

Notice of References Cited

Application/Control No.

10/002,024

Applicant(s)/Patent Under
Reexamination
FUTAGAWA ET AL.

Examiner

Christopher P Bruenjes

Art Unit

1772

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,120,860 ✓	09-2000	Bowen et al.	428/34.2
	B	US-5,387,449 ✓	02-1995	Kunz et al.	428/35.4
	C	US-5,391,423 ✓	02-1995	Wnuk et al.	428/217
	D	US-6,146,726 ✓	11-2000	Yoshii et al.	428/35.9
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	L	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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